


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586509	<b>Applicant(s)/Patent Under Reexamination</b>  TIMPE ET AL.
	<b>Examiner</b>  Eoff, Anca	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
430	270.1, 281.1, 284.1, 287.1, 302, 906, 908, 921, 922, 944	3/9/2009	AE

SEARCH NOTES		
Search Notes	Date	Examiner
Text search in EAST (see history attached)	3/9/2009	AE
Consulted with Primary Examiners Sin Lee and John Chu regarding the patentability of the application	3/9/2009	AE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
430	270.1, 281.1, 284.1, 287.1, 302, 906, 908, 921, 922, 944	3/9/2009	AE

/A. E./ Examiner.Art Unit 1795	
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